

Notice of References Cited	Application/Control No. 10/758,486		Applicant(s)/Patent Under Reexamination ABDO ET AL.	
	Examiner GIOVANNA COLAN		Art Unit 2162	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,785,677	08-2004	Fritchman, Barry Lynn	707/6
*	B	US-2002/0198867	12-2002	Lohman et al.	707/3
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Haas et al. (NPL: "Sampling - Based Selectivity for joins Using Augmented Frequent Value Statistics", Peter J. Haas, Arun N. Swami, IBM Almaden Research Center, San JOse CA, 1995, IEEE)
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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